

**Search Notes**

Application/Control No.

10/774,883

Examiner

Phallaka Kik

Applicant(s)/Patent under  
Reexamination

FUNG ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	6,9,10,16, 18	2/3/2006	PK
716	16,18	2/7/2006	PK
Above	updated	5/27/2006	PK
Above	updated	8/21/2006	PK
Above	updated	12/6/2006	PK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
716	6,9,10,16	12/7/2006	PK
716	18	12/7/2006	PK
-USPGPUB (see attached)		12/7/2006	PK

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
BRS (EAST) -USPAT, USPGPUB Class/sub searched: 716/1-18 (see attached)	2/3/2006	PK
Above updated (see attached)	5/27/2006	PK
Above updated (see attached)	8/21/2006	PK
Above updated (see attached)	12/6/2006	PK
-EPO, JPO, IBM TDB, Derwent (see attached)	2/3/2006	PK
IEE/IEEE Xplore (see attached)	2/3/2006	PK